# **MOSFET** - N-Channel, Logic Level, POWERTRENCH® **60 V, 4 A, 60 m**Ω



## ON Semiconductor®

#### www.onsemi.com



**TSOT23-6** CASE 419BL

#### **MARKING DIAGRAM**



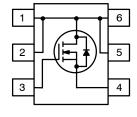
XXX = Specific Device Code

= Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

## **PIN CONNECTIONS**



#### ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

# FDC5661N-F085

#### **Features**

- $R_{DS(on)} = 47 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 4.3 \text{ A}$
- $R_{DS(on)} = 60 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 4 \text{ A}$
- Typ  $Q_{g(TOT)} = 14.5 \text{ nC}$  at  $V_{GS} = 10 \text{ V}$
- Low Miller Charge
- UIS Capability
- AEC-Q101 Qualified and PPAP Capable
- This Device is Pb-Free, Halogen Free/BFR Free and is RoHS Compliant

### **Applications**

- DC/DC Converter
- Motor Drives

#### MOSFET MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain to Source Voltage	$V_{DSS}$	60	V
Gate to Source Voltage	V <sub>GS</sub>	±20	V
Drain Current Continuous (V <sub>GS</sub> = 10 V)	I <sub>D</sub>	4.3	Α
Pulsed		20	
Single Pulse Avalanche Energy (Note 1)	E <sub>AS</sub>	81	mJ
Power Dissipation	P <sub>D</sub>	1.6	W
Operating and Storage Temperature	T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C
Thermal Resistance Junction to Case	$R_{ heta JC}$	30	°C/W
Thermal Resistance Junction to Ambient TO-263, 1in <sup>2</sup> Copper Pad Area	$R_{\theta JA}$	78	°C/W

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

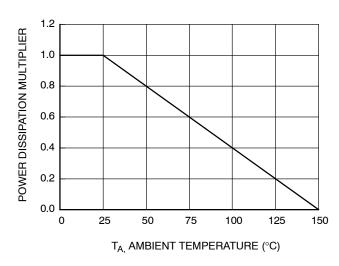
1.  $E_{AS}$  of 81 mJ is 100% test at L = 14 mH,  $I_{AS}$  = 3.4 A, Starting  $T_J$  = 25°C

# **ELECTRICAL CHARACTERISTICS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		•	•		
Drain to Source Breakdown Voltage	B <sub>VDSS</sub>	$I_D = 250 \mu A, V_{GS} = 0 V$	60	_	_	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
		T <sub>A</sub> = 150°C	-	-	250	1
Gate to Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V	-	-	±100	nA
ON CHARACTERISTICS	•		•		-	-
Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1	2.0	3	V
Drain to Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.3 A	-	38	47	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 4 A	-	46	60	1
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.3 A T <sub>J</sub> = 150°C	-	69	86	1
DYNAMIC CHARACTERISTICS	•	•	•	•		
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1 MHz	_	763	_	pF
Output Capacitance	C <sub>oss</sub>	f = 1 MHz	-	68	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	36	-	pF
Gate Resistance	R <sub>G</sub>	f = 1 MHz	-	2.6	_	Ω
Total Gate Charge at 10 V	Q <sub>g(TOT)</sub>	$V_{GS} = 0$ to 10 V, $V_{DD} = 30$ V, $I_D = 4.3$ A	-	14.5	19	nC
Gate to Source Gate Charge	$Q_{gs}$	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 4.3 A	-	2.4	_	nC
Gate to Drain "Miller" Charge	$Q_{gd}$		-	2.9	_	nC
SWITCHING CHARACTERISTICS	•		•		-	-
Turn-On Time	t <sub>on</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 30 V,	_	-	17.6	ns
Turn-On Delay Time	t <sub>d(on)</sub>	$I_D = 4.3 \text{ A}, R_{GS} = 6 \Omega,$	-	7.2	_	ns
Rise Time	t <sub>r</sub>		-	1.6	_	ns
Turn-Off Delay Time	t <sub>d(off)</sub>		-	19.3	_	ns
Fall Time	t <sub>f</sub>		-	3.1	_	ns
Turn-Off Time	t <sub>off</sub>		-	-	36	ns
DRAIN-SOURCE DIODE CHARACTE	RISTICS			-	-	•
Source to Drain Diode Voltage	V <sub>SD</sub>	I <sub>SD</sub> = 4.3 A	_	0.8	1.25	V
		I <sub>SD</sub> = 2.1 A	-	0.8	1.0	
Reverse Recovery Time	t <sub>rr</sub>	I <sub>SD</sub> = 4.3 A, dI <sub>SD</sub> /dt = 100 A/μs	-	18.4	24	ns
Reverse Recovery Charge	Q <sub>rr</sub>		-	10.0	13	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**



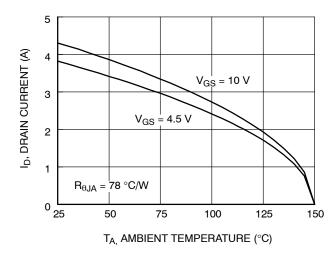


Figure 1. Normalized Power Dissipation vs. Ambient Temperature

Figure 2. Maximum Continuous Drain Current vs. Ambient Temperature

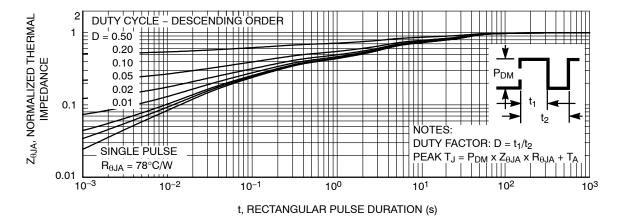


Figure 3. Normalized Maximum Transient Thermal Impedance

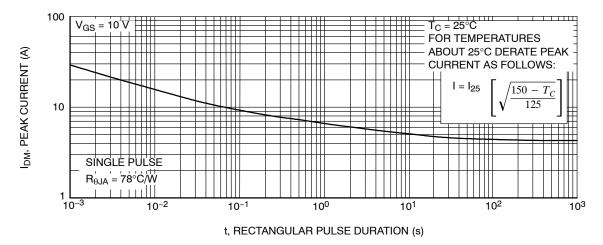


Figure 4. Peak Current Capability

#### TYPICAL CHARACTERISTICS (continued)

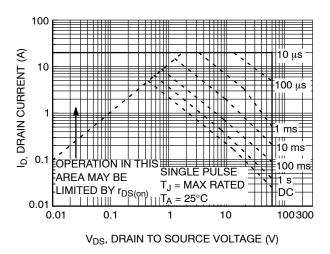


Figure 5. Forward Bias Safe Operating Area

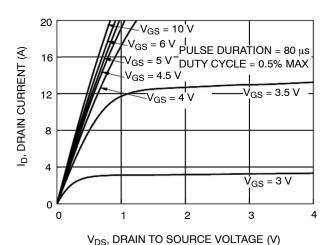


Figure 7. Saturation Characteristics

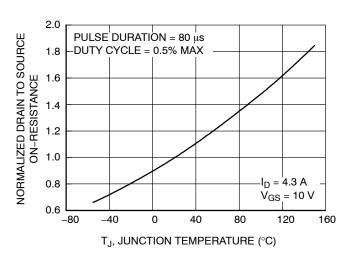


Figure 9. Normalized Drain to Source On Resistance vs. Junction Temperature

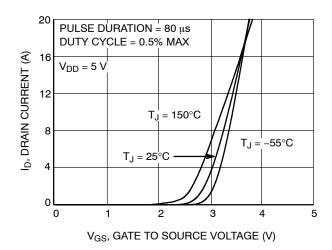


Figure 6. Transfer Characteristics

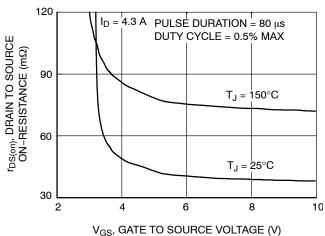


Figure 8. Drain to Source On-Resistance Variation vs. Gate to Source Voltage

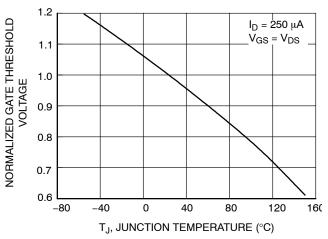


Figure 10. Normalized Gate Threshold Voltage vs. Junction Temperature

# TYPICAL CHARACTERISTICS (continued)

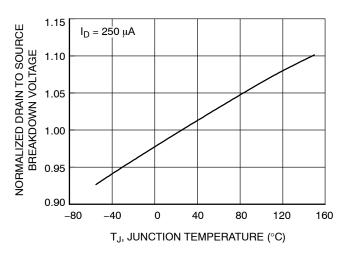


Figure 11. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

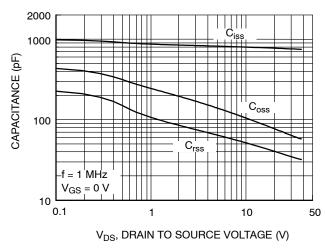


Figure 12. Capacitance vs. Drain to Source Voltage

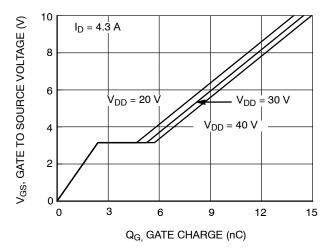


Figure 13. Gate Charge vs. Gate to Source Voltage

### **ORDERING INFORMATION**

Device Marking	Device	Package	Shipping <sup>†</sup>
.661N	FDC5661N-F085	TSOT23-6 (Pb-Free)	3000 / Tape & Reel

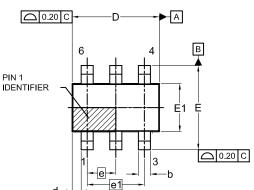
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

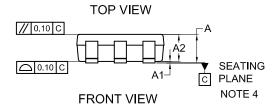
POWERTRENCH is a registered trademark of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries.

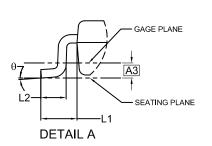


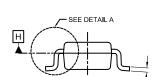
#### TSOT23 6-Lead CASE 419BL **ISSUE A**

**DATE 31 AUG 2020** 









#### SIDE VIEW

03/1414

SYMM
Ę
0.95 <del></del>
1.00 MIN
2.60
0.70 MIN

### LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

# NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
  DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH,
  PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.25MM PER END. DIMENSIONS D AND E1 ARE DETERMINED AT DATUM H.
- 4. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM	MILLIMETERS			
5,101	MIN.	NOM.	MAX.	
Α	0.90	1.00	1.10	
A1	0.00	0.05	0.10	
A2	0.70	0.85	1.00	
A3	0.25 BSC			
b	0.25	0.38	0.50	
С	0.10	0.18	0.26	
D	2.80	2.95	3.10	
d	0.30 REF			
Е	2.50	2.75 3.0		
E1	1.30	1.50	1.70	
е	0.95 BSC			
e1	1.90 BSC			
L1	0.60 REF			
L2	0.20	0.40	0.60	
θ	0°		10°	

#### **GENERIC MARKING DIAGRAM\***



XXX = Specific Device Code

= Date Code Μ

= Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON83292G	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	TSOT23 6-Lead		PAGE 1 OF 1	

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

#### **PUBLICATION ORDERING INFORMATION**

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative